Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/539,461	PARRUCK ET AL.
Examiner	Art Unit
Thien D. Tran	2665

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/466, 538, 539.	9/26/2005	TT
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